#### **DEVICE SPECIFICATIONS**

# NI 6221 (37-Pin)

M Series Data Acquisition: 16 AI, 10 DIO, 2 AO

The following specifications are typical at 25 °C, unless otherwise noted. For more information about the NI PCI-6221 (37-pin), refer to the *M Series User Manual* available at *ni.com/manuals*.

### **Analog Input**

Number of channels	8 differential or 16 single ended		
ADC resolution	16 bits		
DNL	No missing codes guaranteed		
INL	Refer to the AI Absolute Accuracy section		
Sample rate			
Single channel maximum	250 kS/s		
Multichannel maximum (aggregate)	250 kS/s		
Minimum	No minimum		
Timing accuracy	50 ppm of sample rate		
Timing resolution	50 ns		
Input coupling	DC		
Input range	$\pm 0.2 \text{ V}, \pm 1 \text{ V}, \pm 5 \text{ V}, \pm 10 \text{ V}$		
Maximum working voltage for analog inputs (signal + common mode)	±11 V of AI GND		
CMRR (DC to 60 Hz)	92 dB		
Input impedance			
Device on			
AI+ to AI GND	$>$ 10 G $\Omega$ in parallel with 100 pF		
AI- to AI GND	>10 GΩ in parallel with 100 pF		



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AI+ to AI GND	820 Ω
AI- to AI GND	820 Ω
Input bias current	±100 pA
Crosstalk (at 100 kHz)	
Adjacent channels	-75 dB
Non-adjacent channels	-90 dB
Small signal bandwidth (-3 dB)	700 kHz
Input FIFO size	4,095 samples
Scan list memory	4,095 entries
Data transfers	DMA (scatter-gather), interrupts, programmed I/O
Overvoltage protection for all analog input a	nd sense channels
Device on	±25 V for up to two AI pins
Device off	±15 V for up to two AI pins
Input current during overvoltage condition	±20 mA maximum/AI pin

# Settling Time for Multichannel Measurements

Accuracy, full-scale step, all ranges		
±90 ppm of step (±6 LSB)	4 μs convert interval	
±30 ppm of step (±2 LSB)	5 μs convert interval	
$\pm 15$ ppm of step ( $\pm 1$ LSB)	7 μs convert interval	

# Typical Performance Graphs

Figure 1. Settling Error versus Time for Different Source Impedances

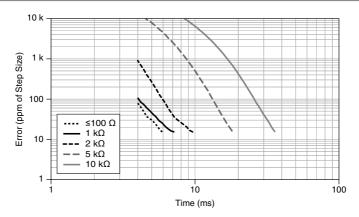
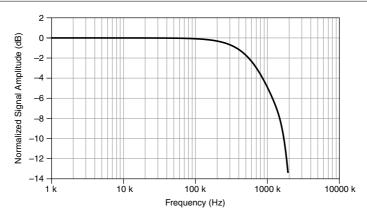
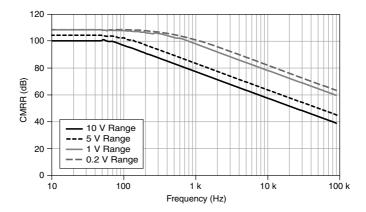


Figure 2. Al Small Signal Bandwidth





### Al Absolute Accuracy



**Note** Accuracies listed are valid for up to one year from the device external calibration.

Table 1. Al Absolute Accuracy

Nominal Range Positive Full Scale	Nominal Range Negative Full Scale	Residual Gain Error (ppm of Reading)	Residual Offset Error (ppm of Range)	Offset Tempco (ppm of Range/°C)	Random Noise, σ (μVrms)	Absolute Accuracy at Full Scale (µV)	Sensitivity (μV)
10	-10	75	20	57	244	3,100	97.6
5	-5	85	20	60	122	1,620	48.8
1	-1	95	25	79	30	360	12.0
0.2	-0.2	135	80	175	13	112	5.2



**Note** Sensitivity is the smallest voltage change that can be detected. It is a function of noise.

Gain tempco	25 ppm/°C
Reference tempco	5 ppm/°C
INL error	76 ppm of range

#### Al Absolute Accuracy Equation

```
AbsoluteAccuracy = Reading \cdot (GainError) + Range \cdot (OffsetError) + NoiseUncertainty
     GainError = ResidualAIGainError + GainTempco \cdot (TempChangeFromLastInternalCal)
     + ReferenceTempco · (TempChangeFromLastExternalCal)
     OffsetError = ResidualAIOffsetError + OffsetTempco
     (TempChangeFromLastInternalCal) + INLError
     NoiseUncertainty = \frac{\text{Random Noise} \cdot 3}{\sqrt{100}} for a coverage factor of 3 \sigma and averaging
     100 points.
```

#### Al Absolute Accuracy Example

Absolute accuracy at full scale on the analog input channels is determined using the following assumptions:

- TempChangeFromLastExternalCal = 10 °C
- TempChangeFromLastInternalCal = 1 °C
- number of readings = 100
- CoverageFactor =  $3 \sigma$

For example, on the 10 V range, the absolute accuracy at full scale is as follows:

GainError = 75 ppm + 25 ppm · 1 + 5 ppm · 10 = 150 ppm   
OffsetError = 20 ppm + 57 ppm · 1 + 76 ppm = 153 ppm   
NoiseUncertainty = 
$$\frac{244 \ \mu V \cdot 3}{\sqrt{100}}$$
 = 73  $\mu V$ 

AbsoluteAccuracy = 10 V · (GainError) + 10 V · (OffsetError) + NoiseUncertainty =  $3,100 \mu V$ 

## Analog Output

2
16 bits
±1 LSB
16 bit guaranteed
833 kS/s
740 kS/s per channel
50 ppm of sample rate
50 ns
±10 V

Output coupling	DC
Output impedance	0.2 Ω
Output current drive	±5 mA
Overdrive protection	±25 V
Overdrive current	10 mA
Power-on state	±20 mV
Power-off glitch	400 mV for 200 ms
Output FIFO size	8,191 samples shared among channels used
Data transfers	DMA (scatter-gather), interrupts, programmed I/O
AO waveform modes	Non-periodic waveform, periodic waveform regeneration mode from onboard FIFO, periodic waveform regeneration from host buffer including dynamic update
Settling time, full-scale step, 15 ppm (1 LSB)	6 µs
Slew rate	15 V/μs
Glitch energy	
Magnitude	100 mV
Duration	2.6 μs

### **AO Absolute Accuracy**

Absolute accuracy at full-scale numbers is valid immediately following internal calibration and assumes the device is operating within 10 °C of the last external calibration.



**Note** Accuracies listed are valid for up to one year from the device external calibration.

Table 2. AO Absolute Accuracy

Nominal Range Positive Full Scale	Nominal Range Negative Full Scale	Residual Gain Error (ppm of Reading)	Gain Tempco (ppm/°C)	Residual Offset Error (ppm of Range)	Offset Tempco (ppm of Range/°C)	Absolute Accuracy at Full Scale (µV)
10	-10	90	10	40	5	3,230

Reference tempco	5 ppm/°C
INL error	128 ppm of range

#### **AO Absolute Accuracy Equation**

 $AbsoluteAccuracy = OutputValue \cdot (GainError) + Range \cdot (OffsetError)$ 

 $GainError = ResidualGainError + GainTempco \cdot (TempChangeFromLastInternalCal) +$ 

ReferenceTempco · (TempChangeFromLastExternalCal)

OffsetError = ResidualOffsetError + AOOffsetTempco

(TempChangeFromLastInternalCal) + INLError

### Digital I/O/PFI

#### Static Characteristics

Number of channels	10 total, 2 (P0.<0, 1>), 8 (PFI <07>/P1)
Ground reference	D GND
Direction control	Each terminal individually programmable as input or output
Pull-down resistor	$50 \text{ k}\Omega$ typical, $20 \text{ k}\Omega$ minimum
Input voltage protection	±20 V on up to two pins <sup>1</sup>

### Waveform Characteristics (Port 0 Only)

Terminals used	Port 0 (P0.<0,1>)
Port/sample size	Up to 2 bits
Waveform generation (DO) FIFO	2,047 samples
Waveform acquisition (DI) FIFO	2,047 samples
DI or DO Sample Clock frequency	0 MHz to 1 MHz, system and bus activity dependent
Data transfers	DMA (scatter-gather), interrupts, programmed I/O
DI or DO Sample Clock source <sup>2</sup>	Any PFI, RTSI, AI Sample or Convert Clock, AO Sample Clock, Ctr <i>n</i> Internal Output, and many other signals

<sup>&</sup>lt;sup>1</sup> Stresses beyond those listed under *Input voltage protection* may cause permanent damage to the device.

<sup>&</sup>lt;sup>2</sup> The digital subsystem does not have its own dedicated internal timing engine. Therefore, a sample clock must be provided from another subsystem on the device or an external source.

# PFI/Port 1 Functionality

Functionality	Static digital input, static digital output,
	timing input, timing output
Timing output sources	Many AI, AO, counter, DI, DO timing signals
Debounce filter settings	$125$ ns, $6.425~\mu s, 2.56$ ms, disable; high and
	low transitions; selectable per input

# **Recommended Operating Conditions**

Level	Minimum	Maximum
Input high voltage (V <sub>IH</sub> )	2.2 V	5.25 V
Input low voltage (V <sub>IL</sub> )	0 V	0.8 V
Output high current (I <sub>OH</sub> ) P0.<0,1>	-	-24 mA
Output high current (I <sub>OH</sub> ) PFI <07>/P1	-	-16 mA
Output low current (I <sub>OL</sub> ) P0.<0,1>	-	24 mA
Output low current (I <sub>OL</sub> ) PFI <07>/P1	-	16 mA

#### **Electrical Characteristics**

Level	Minimum	Maximum
Positive-going threshold (VT+)	_	2.2 V
Negative-going threshold (VT-)	0.8 V	_
Delta VT hystersis (VT+ - VT-)	0.2 V	_
$I_{IL}$ input low current ( $V_{in} = 0 \text{ V}$ )	_	-10 μΑ
$I_{IH}$ input high current ( $V_{in} = 5 \text{ V}$ )	_	250 μΑ

# Digital I/O Characteristics

Figure 4. P0.<0,1>: Ioh versus Voh

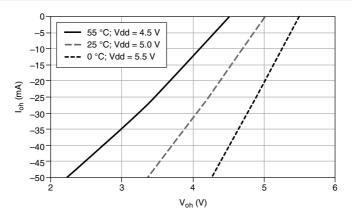
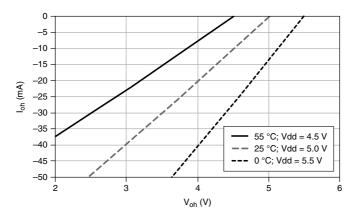


Figure 5. PFI <0..7>/P1:  $I_{oh}$  versus  $V_{oh}$ 



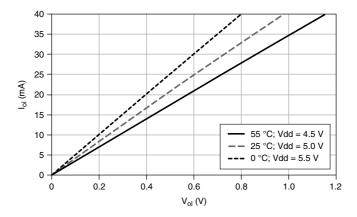
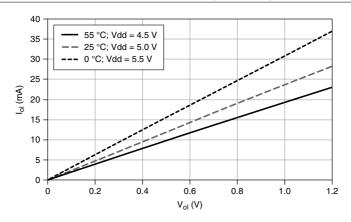


Figure 7. PFI <0..7>/P1: I<sub>ol</sub> versus V<sub>ol</sub>



# General-Purpose Counters/Timers

Number of counter/timers	2
Resolution	32 bits
Counter measurements	Edge counting, pulse, semi-period, period, two-edge separation
Position measurements	X1, X2, X4 quadrature encoding with Channel Z reloading; two-pulse encoding
Output applications	Pulse, pulse train with dynamic updates, frequency division, equivalent time sampling

Internal base clocks	80 MHz, 20 MHz, 0.1 MHz
External base clock frequency	0 MHz to 20 MHz
Base clock accuracy	50 ppm
Inputs	Gate, Source, HW_Arm, Aux, A, B, Z, Up_Down
Routing options for inputs	Any PFI, RTSI, PXI_TRIG, PXI_STAR, analog trigger, many internal signals
Routing options for inputs	Any PFI, RTSI, analog trigger, many internal signals
FIFO	2 samples
Data transfers	Dedicated scatter-gather DMA controller for each counter/timer; interrupts; programmed I/O

# Frequency Generator

Number of channels	1
Base clocks	10 MHz, 100 kHz
Divisors	1 to 16
Base clock accuracy	50 ppm

Output can be available on any output PFI or RTSI terminal.

# Phase-Locked Loop (PLL)

Number of PLLs	1
Reference signal	RTSI <07>
Output of PLL	80 MHz Timebase; other signals derived from 80 MHz Timebase including 20 MHz and 100 kHz Timebases

# **External Digital Triggers**

Source	Any PFI, RTSI
Polarity	Software-selectable for most signals

Analog input function	Start Trigger, Reference Trigger, Pause Trigger, Sample Clock, Convert Clock, Sample Clock Timebase
Analog output function	Start Trigger, Pause Trigger, Sample Clock, Sample Clock Timebase
Counter/timer function	Gate, Source, HW_Arm, Aux, A, B, Z, Up_Down
Digital waveform generation (DO) function	Sample Clock
Digital waveform acquisition (DI) function	Sample Clock

# Device-to-Device Trigger Bus

Trigger bus	RTSI <07>
Output selections	10 MHz Clock, frequency generator output, many internal signals
Debounce filter settings	125 ns, 6.425 μs, 2.56 ms, disable; high and low transitions; selectable per input

# **Bus Interface**

Bus interface	3.3 V or 5 V signal environment
DMA channels	6, can be used for analog input, analog output, digital input, digital output, counter/timer 0, counter/timer 1

# Power Requirements

d condition <sup>3</sup>
0.27 A
0.15 A
AO overvoltage condition <sup>3</sup>
0.27 A
0.25 A

<sup>&</sup>lt;sup>3</sup> Does not include P0/PFI/P1 terminals.

### Physical Characteristics

Dimensions	10.6 cm × 15.5 cm (4.2 in. × 6.1 in.)
Weight	95 g (3.3 oz)
I/O connector	37-pin D-SUB

#### Calibration

Recommended warm-up time	15 minutes
Calibration interval	1 year

# Maximum Working Voltage

Maximum working voltage refers to the signal voltage plus the common-mode voltage.

Channel-to-earth	11 V, Measurement Category I
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Measurement Category I is for measurements performed on circuits not directly connected to the electrical distribution system referred to as MAINS voltage. MAINS is a hazardous live electrical supply system that powers equipment. This category is for measurements of voltages from specially protected secondary circuits. Such voltage measurements include signal levels, special equipment, limited-energy parts of equipment, circuits powered by regulated lowvoltage sources, and electronics.



**Caution** Do not use for measurements within Categories II, III, or IV.



**Note** Measurement Categories CAT I and CAT O (Other) are equivalent. These test and measurement circuits are not intended for direct connection to the MAINS building installations of Measurement Categories CAT II, CAT III, or CAT IV.

#### Environmental

0 °C to 55 °C
-20 °C to 70 °C
10% RH to 90% RH, noncondensing
2,000 m
2

Indoor use only.

## Safety

This product is designed to meet the requirements of the following electrical equipment safety standards for measurement, control, and laboratory use:

- IEC 61010-1, EN 61010-1
- UL 61010-1, CSA 61010-1



**Note** For UL and other safety certifications, refer to the product label or the *Online* Product Certification section.

### Electromagnetic Compatibility

This product meets the requirements of the following EMC standards for electrical equipment for measurement, control, and laboratory use:

- EN 61326-1 (IEC 61326-1): Class A emissions; Basic immunity
- EN 55011 (CISPR 11): Group 1, Class A emissions
- EN 55022 (CISPR 22): Class A emissions
- EN 55024 (CISPR 24): Immunity
- AS/NZS CISPR 11: Group 1, Class A emissions
- AS/NZS CISPR 22: Class A emissions
- FCC 47 CFR Part 15B: Class A emissions
- ICES-001: Class A emissions



**Note** In the United States (per FCC 47 CFR), Class A equipment is intended for use in commercial, light-industrial, and heavy-industrial locations. In Europe, Canada, Australia and New Zealand (per CISPR 11) Class A equipment is intended for use only in heavy-industrial locations.



**Note** Group 1 equipment (per CISPR 11) is any industrial, scientific, or medical equipment that does not intentionally generate radio frequency energy for the treatment of material or inspection/analysis purposes.



**Note** For EMC declarations and certifications, and additional information, refer to the Online Product Certification section.

# CE Compliance ( €

This product meets the essential requirements of applicable European Directives, as follows:

- 2014/35/EU; Low-Voltage Directive (safety)
- 2014/30/EU; Electromagnetic Compatibility Directive (EMC)
- 2011/65/EU; Restriction of Hazardous Substances (RoHS)

### Online Product Certification

Refer to the product Declaration of Conformity (DoC) for additional regulatory compliance information. To obtain product certifications and the DoC for this product, visit ni.com/ certification, search by model number or product line, and click the appropriate link in the Certification column

### **Environmental Management**

NI is committed to designing and manufacturing products in an environmentally responsible manner. NI recognizes that eliminating certain hazardous substances from our products is beneficial to the environment and to NI customers.

For additional environmental information, refer to the Minimize Our Environmental Impact web page at ni.com/environment. This page contains the environmental regulations and directives with which NI complies, as well as other environmental information not included in this document.

### Waste Electrical and Electronic Equipment (WEEE)

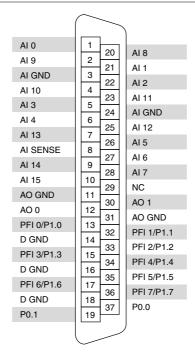
X **EU Customers** At the end of the product life cycle, all NI products must be disposed of according to local laws and regulations. For more information about how to recycle NI products in your region, visit ni.com/environment/weee.

### 电子信息产品污染控制管理办法(中国 RoHS)

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#### **Device Pinout**

Figure 8. NI PCI-6221 (37-Pin) Pinout



NC = No Connect

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